Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,441	SUEN ET AL.	
Examiner	Art Unit	
Eric Chang	2116	

SEARCHED					
Class	Subclass	Date	Examiner		
713	401	9/20/2007	EC		
:					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST USPAT/PGPUB EPO/JPO	9/20/2007	EC	